


<b>Search Notes</b> 	<b>Application/Control No.</b> 10580464	<b>Applicant(s)/Patent Under Reexamination</b> YAMASHITA ET AL.
	<b>Examiner</b> SING P CHAN	<b>Art Unit</b> 1791

### SEARCHED

Class	Subclass	Date	Examiner
156	230, 235, 239, 241, 247, 249	12/4/08	SPC
315	169.3	12/4/08	SPC
345	45	12/4/08	SPC
438	30, 455, 458	12/4/08	SPC
156	230, 235, 239, 241, 247, 249	5/21/09	SPC
315	169.3	5/21/09	SPC
345	45	5/21/09	SPC
438	30, 455, 458	5/21/09	SPC

### SEARCH NOTES

Search Notes	Date	Examiner
Text and image search on EAST	12/4/08	SPC
Inventors search on EAST and PALM on akio yamashita, yumiko fukumoto, yuugo goto	12/4/08	SPC
PGPUB text search on EAST	12/4/08	SPC
Text and image search on EAST	5/21/09	SPC
Inventors search on EAST and PALM on akio yamashita, yumiko fukumoto, yuugo goto	5/21/09	SPC
Interference search on EAST	5/21/09	SPC

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
156	230, 235, 239, 241, 247, 249	5/21/09	SPC
315	169.3	5/21/09	SPC
345	45	5/21/09	SPC
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